

N-channel 900 V, 1.90 Ω typ., 4 A MDmesh™ K5 Power MOSFET in a TO-220FP package

Datasheet - production data

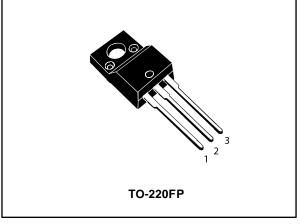
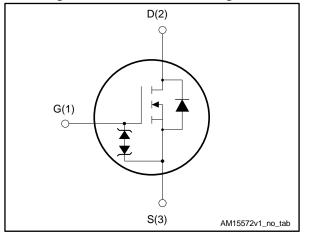


Figure 1: Internal schematic diagram



Features

Order code	VDS	R _{DS(on)} max.	ID	
STF4N90K5	900 V	2.10 Ω	4 A	

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh[™] K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STF4N90K5	4N90K5	TO-220FP	Tube

DocID029957 Rev 2

This is information on a product in full production.

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vgs	Gate-source voltage	± 30	V
ID	Drain current (continuous) at T_C = 25 °C	4(1)	А
lь	Drain current (continuous) at Tc = 100 °C	2.5 ⁽¹⁾	А
ID ⁽²⁾	Drain current (pulsed)	16	А
P _{TOT}	Total dissipation at $T_C = 25 \ ^{\circ}C$	20	W
dv/dt (3)	Peak diode recovery voltage slope	4.5	1//20
dv/dt (4)	MOSFET dv/dt ruggedness	50	V/ns
Viso	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; TC = 25 °C)	2500	V
Tj	Operating junction temperature range	55 to 150	.0°
T _{stg}	Storage temperature range	- 55 to 150	C

Notes:

⁽¹⁾Limited by package

 $^{(2)}\mbox{Pulse}$ width limited by safe operating area

 $^{(3)}\text{I}_{\text{SD}} \leq 4$ A, di/dt \leq 100 A/µs; V_Ds peak < V_{(BR)DSS}, V_DD = 450 V.

 $^{(4)}\mathsf{V}_\mathsf{DS} \leq 720 \; \mathsf{V}$

Table 3: Thermal data

Symbol Parameter		Value	Unit	
R _{thj} -case	R _{thj-case} Thermal resistance junction-case			
R _{thj-amb}	Rthj-amb Thermal resistance junction-ambient			

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	1	А
E _{AS}	AS Single pulse avalanche energy (starting $T_j = 25 \text{ °C}$, $I_D = I_{AR}$, $V_{DD} = 50 \text{ V}$)		



2 Electrical characteristics

 $T_C = 25$ °C unless otherwise specified

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
V _{(BR)DSS}	Drain-source breakdown voltage	V_{GS} = 0 V, I_D = 1 mA	900			V		
IDSS	Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 900 V$			1	μA		
		$V_{GS} = 0 V, V_{DS} = 900 V$ T _c = 125 °C ⁽¹⁾			50	μA		
I _{GSS}	Gate body leakage current	V_{DS} = 0 V, V_{GS} = ±20 V			±10	μA		
VGS(th)	Gate threshold voltage	$V_{DD} = V_{GS}$, $I_D = 100 \ \mu A$	3	4	5	V		
R _{DS(on)}	Static drain-source on-resistance	V_{GS} = 10 V, I _D = 1.5 A		1.90	2.10	Ω		

Table 5: On/off-state

Notes:

⁽¹⁾ Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	173	-	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 V	-	17.9	-	pF
Crss	Reverse transfer capacitance	163 - 0 1	-	1	-	pF
Co(tr) ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 720 V,	-	29	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	$V_{GS} = 0 V$	-	11	-	pF
Rg	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	-	15.5	-	Ω
Qg	Total gate charge	$V_{DD} = 720 \text{ V}, \text{ I}_{D} = 3 \text{ A}$	-	5.3	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	1.45	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15: "Test circuit for gate charge behavior")	-	2.8	-	nC

Table 6: Dynamic

Notes:

 $^{(1)}$ Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

 $^{(2)}$ Energy related is defined as a constant equivalent capacitance giving the same stored energy as Coss when VDs increases from 0 to 80% VDss.



Electrical characteristics

_	Table 7: Switching times							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
t _{d(on)}	Turn-on delay time	V_{DD} = 450 V, I_D = 1.50 A,	-	10.5	-	ns		
tr	Rise time	$R_G = 4.7 \Omega$; $V_{GS} = 10 V$ (see Figure 14: "Test circuit for resistive load switching times" and Figure 19: "Switching time waveform")	I	11.8	-	ns		
t _{d(off)}	Turn-off delay time		-	26.4	-	ns		
tr	Fall time		-	25.5	-	ns		

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isd	Source-drain current		-		4	А
Isdm ⁽¹⁾	Source-drain current (pulsed)		-		16	А
Vsd ⁽²⁾	Forward on voltage	$I_{SD} = 3 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	-		1.5	V
t _{rr}	Reverse recovery time	$I_{SD} = 3 \text{ A}, \text{ di/dt} = 100$	-	289		ns
Qrr	Reverrse recovery charge	A/μs,V _{DD} = 60 V (see <i>Figure 16: "Test circuit</i>	-	1.56		μC
I _{RRM}	Reverse recovery current	for inductive load switching and diode recovery times")	-	10.8		А
trr	Reverse recovery time	$I_{SD} = 3 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	494		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, \text{ T}_{j} = 150 ^{\circ}\text{C}$ (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	2.45		μC
Irrm	Reverse recovery current		-	9.9		A

Notes:

⁽¹⁾Pulse width limited by safe operating area

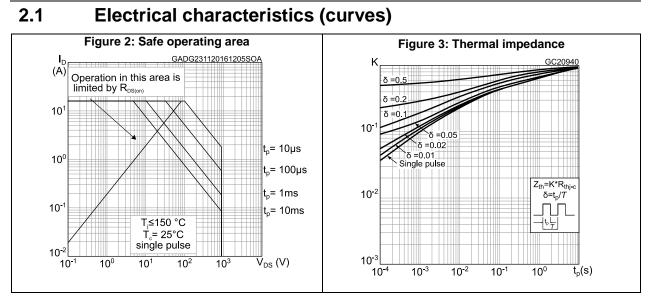
 $^{(2)}$ Pulsed: pulse duration = 300 $\mu s,$ duty cycle 1.5%

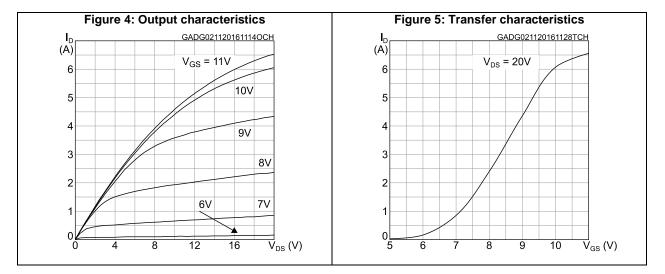
Table 9: Gate-source Zener diode

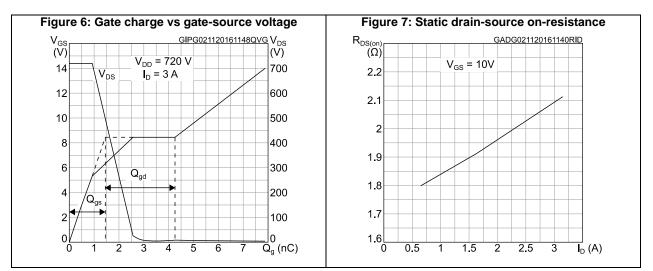
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.







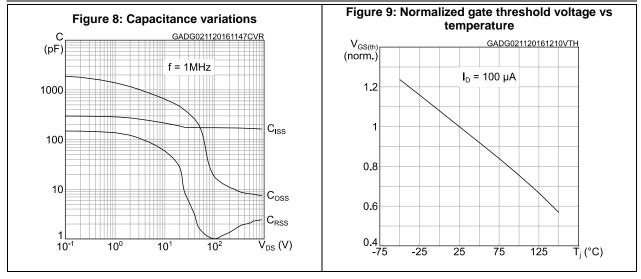


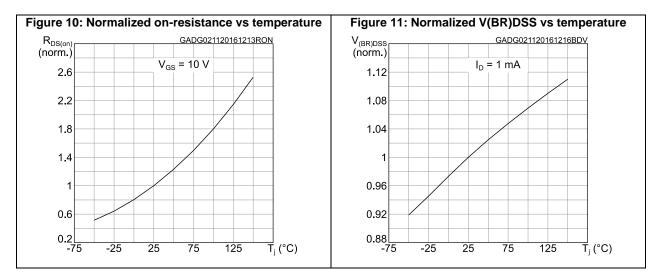
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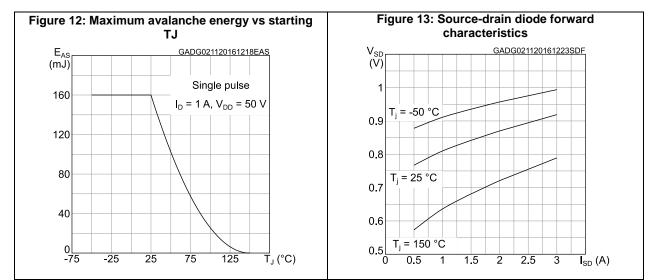


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Electrical characteristics



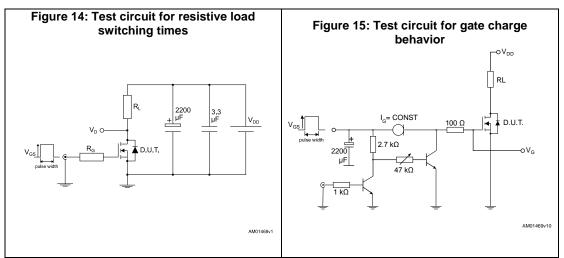


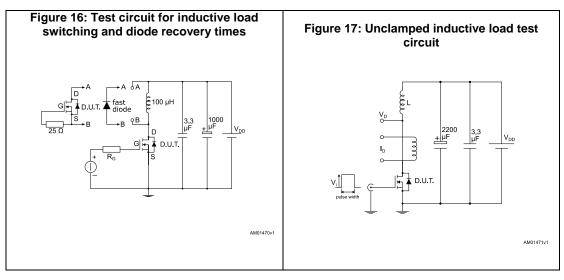


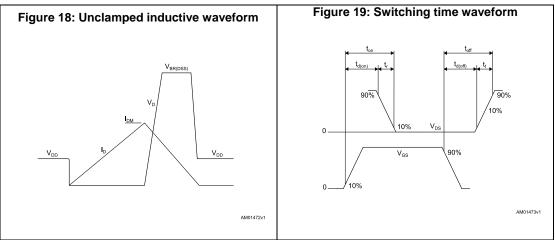
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3 Test circuits







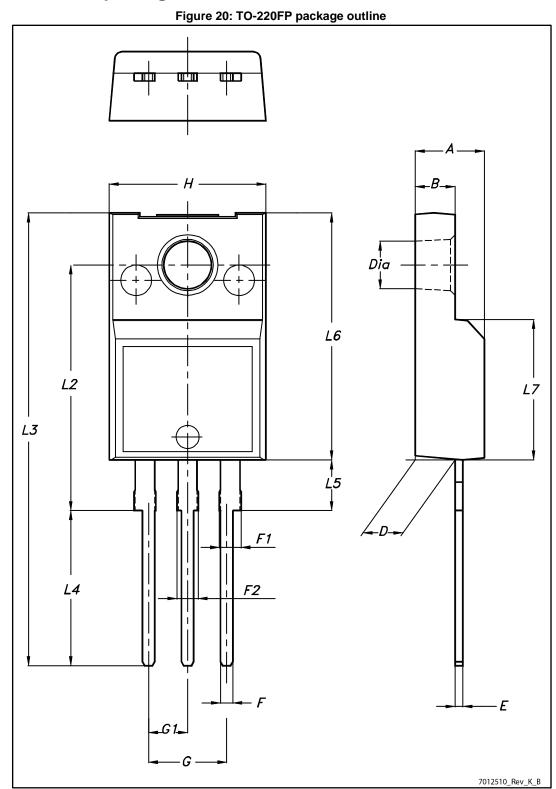


4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.









(5			Package information					
Table 10: TO-220FP package mechanical data								
Dim.		mm						
Dim.	Min.	Тур.	Max.					
A	4.4		4.6					
В	2.5		2.7					
D	2.5		2.75					
E	0.45		0.7					
F	0.75		1					
F1	1.15		1.70					
F2	1.15		1.70					
G	4.95		5.2					
G1	2.4		2.7					
Н	10		10.4					
L2		16						
L3	28.6		30.6					
L4	9.8		10.6					
L5	2.9		3.6					
L6	15.9		16.4					
L7	9		9.3					
Dia	3		3.2					



5 Revision history

Table 11: Document revision history

Date	Revision	Changes
02-Nov-2016	1	First release.
23-Nov-2016	2	Updated <i>Figure 2: "Safe operating area"</i> . Minor text changes.



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